

FORM PTO-1449 (Modified) INFORMATION DISCLOSURE CITATION IN AN APPLICATION (Use several sheets if necessary)	Docket No. P0298US-7	Application Number 10/666,399
	Applicants LEUNG, MICHAEL S.	
	Filing Date September 18, 2003	Group Art Unit 2814

[illegible][illegible]

US PUBLICATION NO. US 2007/0096131 A1, 05/03/2007, CHANDRA	
Examiner /Abul Kalam/	Date Considered 04/10/2008
<p>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>	

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /AK/

U.S. PATENT DOCUMENTS[illegible][illegible]

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U.S. PATENT DOCUMENTS

Examiner Initial	Document Number							Date	Name	Class	Subclass	Filing Date If Appropriate
	6	2	0	1	2	6	2	03/2001	EDMOND et al.	257	77	
	6	1	8	7	6	0	6	02/2001	EDMOND et al.	438	46	
	6	1	2	0	6	0	0	09/2000	EDMOND et al.	117	89	
	6	0	6	9	4	4	0	05/2000	SHIMIZU et al.	313	486	
	5	9	1	2	4	7	7	06/1999	NEGLEY	257	95	
	5	8	5	8	2	7	8	01/1999	ITOH et al.	252	301.4R	
	5	7	3	9	5	5	4	04/1998	EDMOND et al.	257	103	
	5	6	3	1	1	9	0	05/1997	NEGLEY	438	33	
	5	6	0	4	1	3	5	02/1997	EDMOND et al.	437	22	
	5	5	2	3	5	8	9	06/1996	EDMOND et al.	257	77	
	5	4	1	6	3	4	2	05/1995	EDMOND et al.	257	76	

FOREIGN PATENT DOCUMENTS

[illegible]

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

	US PUBLICATION NO. US 2004/0056260 A1, DATE: 03/25/2004, SLATER, JR. et al.
	US PUBLICATION NO. US 2004/0041222 A1, DATE: 03/04/2004, LOH
	US PUBLICATION NO. US 2003/0006418 A1, DATE: 01/09/2003, EMERSON et al.
	US PUBLICATION NO. US 2002/0123164 A1, DATE: 09/05/2002, SLATER, JR. et al.
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Examiner Initial	Document Number							Date	Name	Class	Subclass	Filing Date If Appropriate
	RE	3	4	8	6	1		02/1995	DAVIS et al.	437	100	
	4	9	4	6	5	4	7	08/1990	PALMOUR et al.	156	643	
	5	2	0	0	0	2	2	04/1993	KONG et al.	156	612	
	7	0	4	9	1	5	9	05/2006	LOWERY	438	22	
	6	6	5	3	7	6	5	11/2003	LEVINSON	313	112	
	6	9	1	9	6	8	3	07/2005	JANG, JAE-EUN	313	503	
	6	7	9	1	1	1	9	09/2004	SLATER, JR. et al.	257	99	
	6	9	5	8	4	9	7	10/2005	EMERSON et al.	257	94	
	6	8	5	3	0	1	0	02/2005	SLATER, JR. et al.	257	98	
	7	2	0	2	5	9	8	04/2007	JUESTEL et al.	313	503	

FOREIGN PATENT DOCUMENTS

	Document Number							Date	Country	Class	Subclass	Translation	
												Yes	No
	WO	20	06	03	36	95	A2	03/30/06	PCT				
	WO	20	06	03	62	51	A1	04/06/06	PCT				
	EP	13	67	6	5			12/03/03	EUROPE				
	EP	11	38	7	4	7		10/04/01	EUROPE				
	EP	10	59	67	8			12/2000	EUROPE				

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	LAU, JOHN, "FLIP-CHIP TECHNOLOGIES", MCGRAW HILL, 1996.
	INTERNATIONAL MATERIALS REVIEWS, "MATERIALS FOR FIELD EMISSION DISPLAYS", A.P. BURDEN 2001.
	U.S. PUBLICATION NO. US 2002/0105266, JUESTEL et al. 08/08/2002.
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